AMENDMENTS TO CLAIMS

- 1. (Previously presented) A magnetic memory cell comprising first and second magneto-resistive devices connected in series, the first magneto-resistive device having a first sense layer, the second magneto-resistive device having a second sense layer, the first and second sense layers having different coercivities and at least one of having different sizes and different material compositions.
- 2. (Original) The memory cell of claim 1, wherein the first and second devices are magnetic tunnel junctions.
- 3. (Previously presented) The memory cell of claim 5, wherein the first magnetic tunnel junction includes the first sense layer and a first pinned layer; and wherein the second magnetic tunnel junction includes the second sense layer and a second pinned layer.
- 4. (Previously presented) The memory cell of claim 5, wherein the sense layers of the first and second devices are back to back; and wherein the sense layers are separated by a layer of non-magnetic material.
- 5. (Previously presented) A magnetic memory cell comprising first and second magnetic tunnel junctions connected in series, the first magnetic tunnel junction having a first sense layer, the second magnetic tunnel junction having a second sense layer, the first and second sense layers having different coercivities, the first and second magnetic tunnel junctions sharing a pinned layer.
- 6. (Previously presented) The memory cell of claim 5, wherein hysteresis PAGE 3/5* RCVD AT 11/17/2004 12:15:59 PM [Eastern Standard Time] * SVR:USPTO-EFXRF-1/1* DNIS:8729319 * CSID:949 454 0898 * DURATION (mm-ss):01-40

- 7. (Original) The memory cell of claim 1, wherein the sense layers in the first and second devices have different shapes.
- 8. (Original) The memory cell of claim 1, wherein the sense layers in the first and second devices have different sizes.
- 9. (Original) The memory cell of claim 1, wherein the sense layers of the first and second devices have different shapes and sizes.
- 10. (Original) The memory cell of claim 1, wherein the sense layers of the first and second devices have different thicknesses.
- 11. (Original) The memory cell of claim 1, wherein the sense layers of the first and second devices are made of different materials.
- 12. (Original) The memory device of claim 1, wherein the first and second devices have distinguishably different delta resistances, whereby the memory cell has at least four distinguishable logic states.

Claims 13-25 (Cancelled).